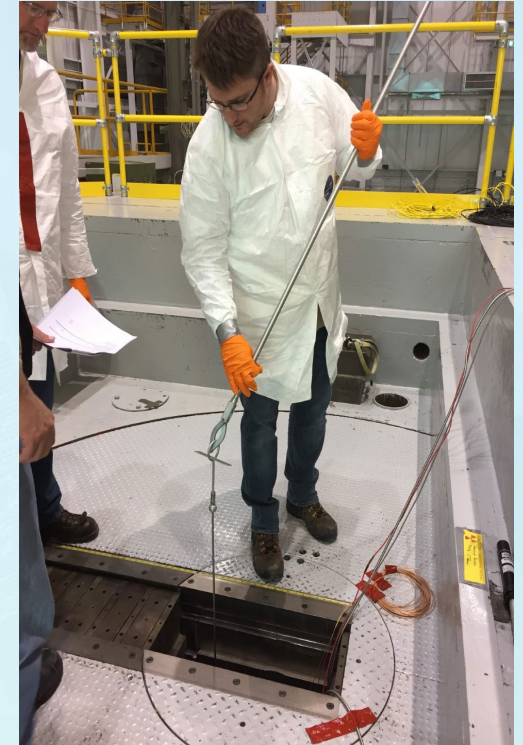


The Development of an in-pile Sensor Qualification Strategy & Device

Austin Fleming, PhD

Irradiation Testing of Instrumentation

- A broad range of needs exist for the development and qualification for in-core sensors
- Low Overhead Testing
 - Provide fast and affordable results on sensor performance (quick and efficient access is prioritized over control and verification of irradiation conditions)
- Performance Testing
 - Measurand is controlled
 - Sensors are generally compared to a modelled value or other sensors
 - Most common type of testing
- Qualification testing
 - Highly controlled experiments with rigorously quantified uncertainties
 - NIST traceability references where possible with statistically significant data sets for a given sensor design

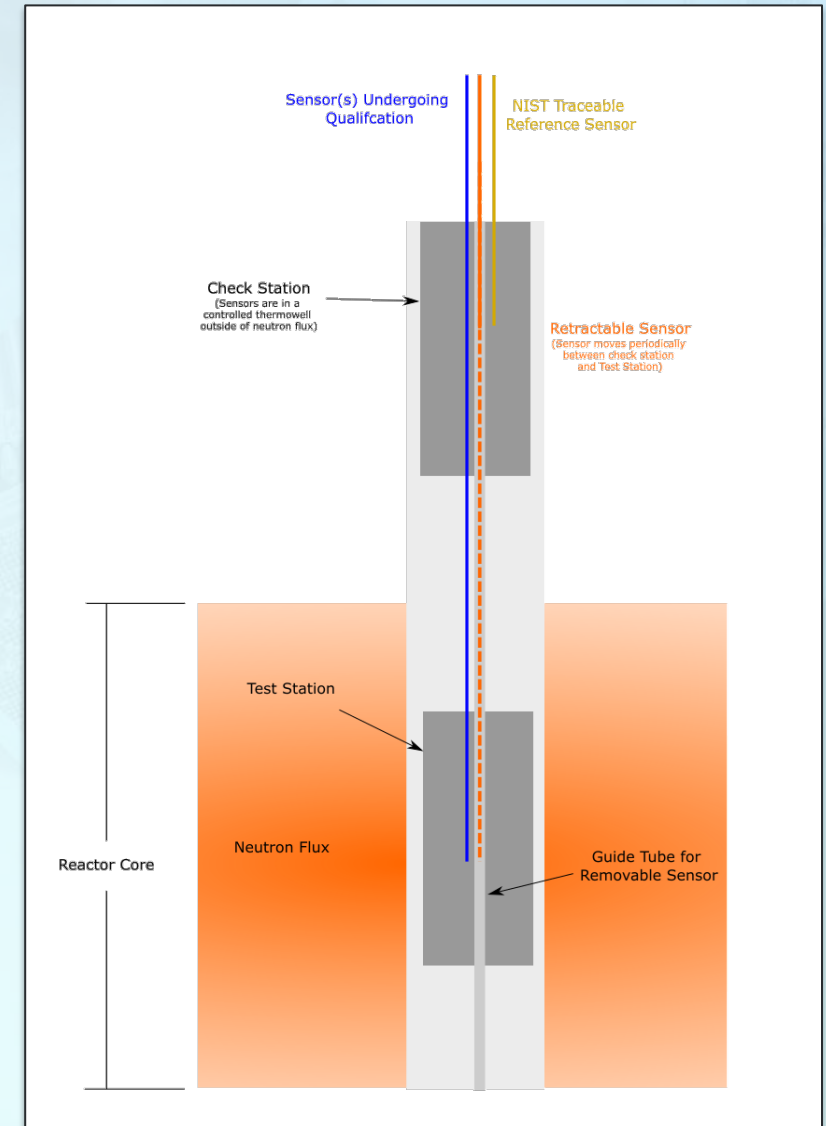


Qualification Testing

- Measurands to qualify
 - Temperature
 - Radiation (neutron & gamma)
 - Pressure
 - Displacement/Strain
- From a survey of needs temperature & radiation are the most needed
- Essentially putting a calibration laboratory inside a reactor
 - Need to provide the conditions in which the sensor is to be qualified
 - Need to know what the conditions are withing some allowable uncertainty band
 - Need to have a statistically significant number of sensors experiencing the conditions to provide an estimation of the performance of sensor design
- For most conditions, if we had a sensor we “trusted” or was qualified for these conditions, we wouldn’t need to qualify one... Chicken and Egg problem

Qualification Testing (continued)

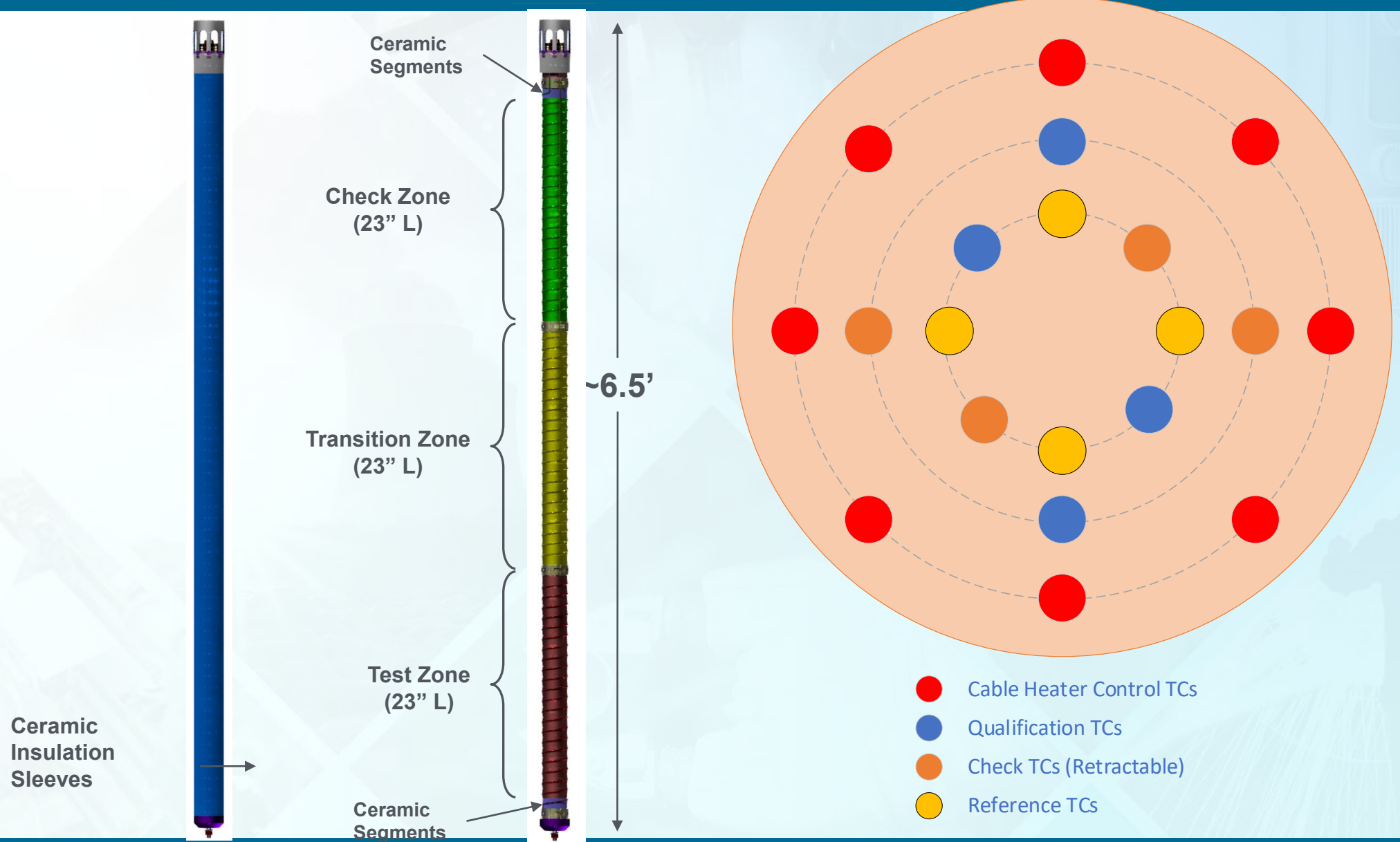
- First device is for temperature sensor qualification
 - Using a two measurement region approach
 - A “retractable” sensor “transfers” the traceability to the in-core sensors
 - At the end of the experiment a closure calibration is conducted to quantify any drift error in the reference sensors
- Different versions will be developed with different target temperatures
 - Low temperature ~500C, aluminum fabrication, low neutron worth and activation
 - Moderate temperature ~800-900 C, covers range of high interest to many advanced reactor designs, higher activating/neutron worth materials
 - High Temperature, refractory metals, ceramics



Qualification Testing positions

- NEET-ASI program is currently identifying possible irradiation positions to perform this qualification testing
- Ideally the device is compatible with several facilities
 - Large positions are desired because of the temperature uniformity requirements, and statistically significant samples
 - Possible positions identified
 - ATR medium I (3.4×10^{13} thermal, 1.3×10^{12} fast, 3.25" diameter)
 - MIT 3GV (4×10^{12} thermal, 3" diameter)
 - OSU 6.5"/9.5" Tubes ($\sim 5 \times 10^{11}$ thermal, 4×10^{11} , 6.5" or 9.5" diameter)
 - NCSU standpipe (1×10^{11} thermal, 5×10^9 fast, 3.5")
- Conceptual design which would fit within a 3" diameter irradiation position

Device Design



Device Design & Prototyping

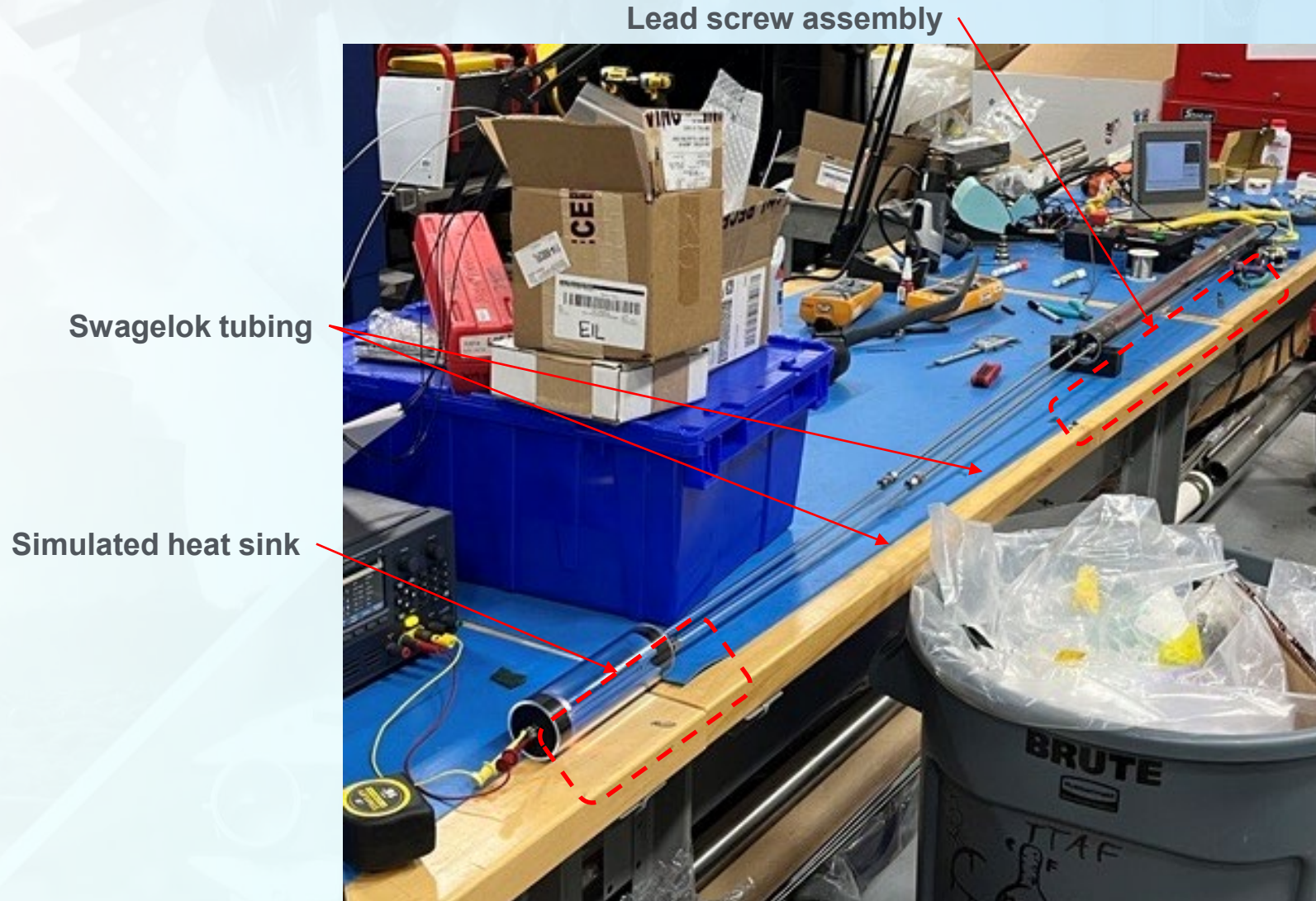


Device Design & Prototyping



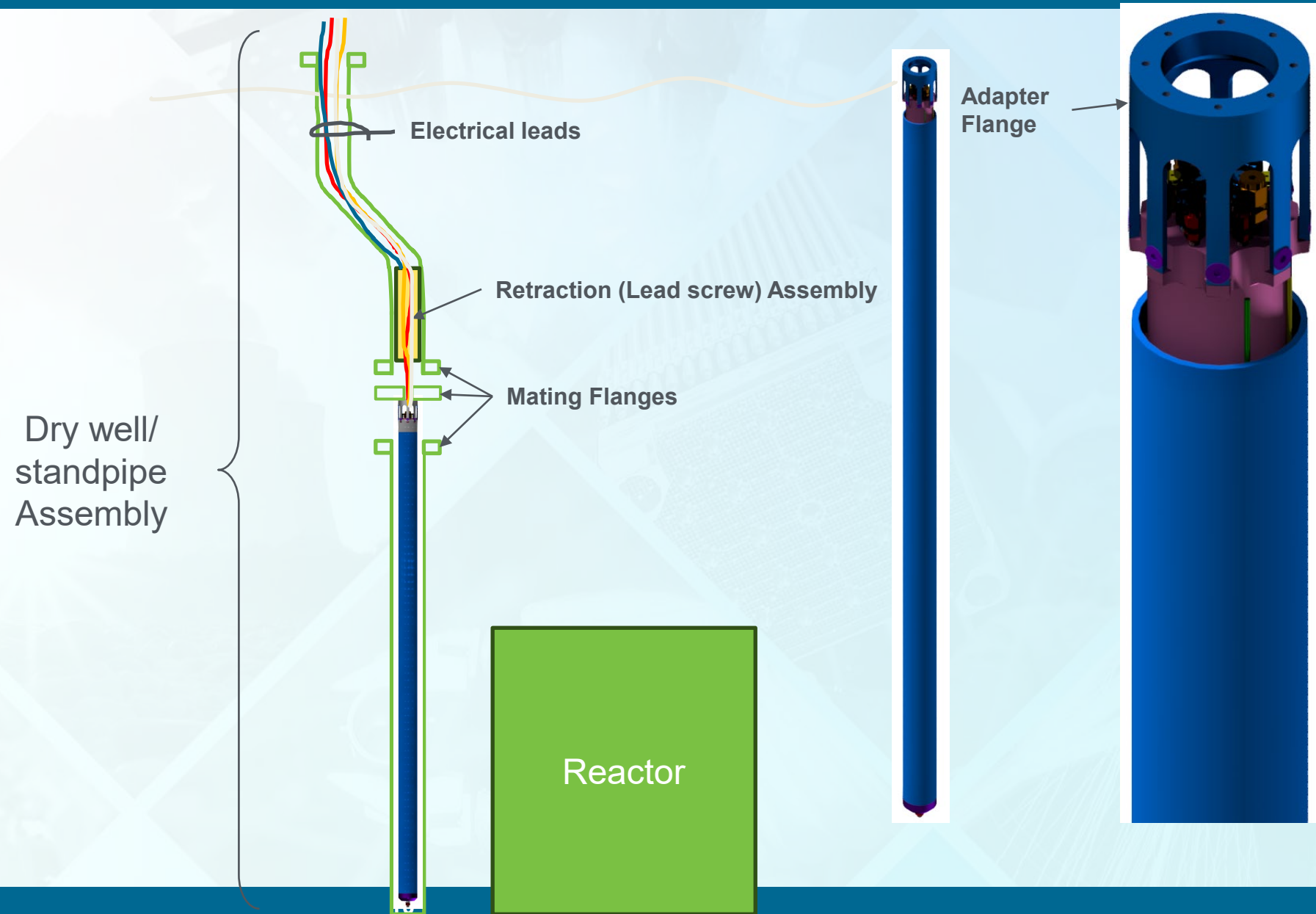
Retraction Assembly

- Lead screw moves TC(s) in and out of TQD
- Concentric tubing is required to address TC buckling during insertion



Installation Concept

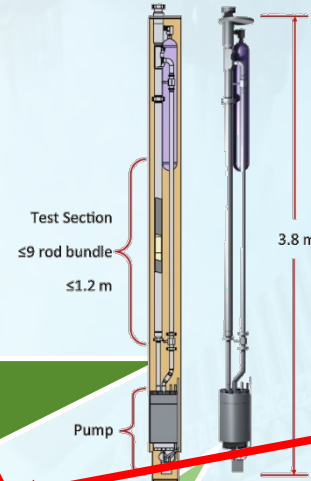
- Dry well/standpipe assembly is totally assembled dry and by hand
- Inserted into pool adjacent to reactor



Qualification Testing

Qualification: science-based approach to show an instrument will operate in established limits for its intended purpose

Experimental Device Integration (mechanical/logistical)



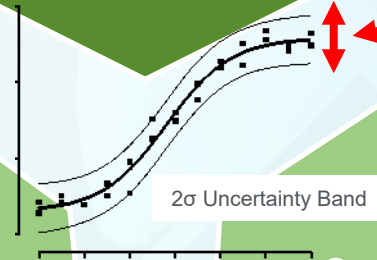
- Geometry
- Feedthroughs
- Connectors
- Leads

Adequate definition = GOAL!



- Flux/fluence
- Electromagnetic environment
- Facility integration

In-Pile Characterization & Testing



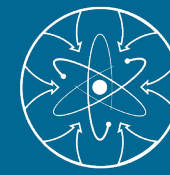
Out-of-Pile Characterization & Testing



- Temperature/Pressure
- Coolants
 - Chemistry/Flow
- Transient response

Summary & concluding thoughts

- We've identified a need to provide more rigorous sensor qualification for several parameters and ranges
- This will rigorously qualify a sensors ability to accurately measure under the ideal conditions. It does not mean the same performance would be achieved under any given application (experiment device integration from previous slide)
 - Ideally no cross-sensitivity to irradiation conditions and sensor integration effects. Therefore out-of-pile testing can establish a bounding uncertainty by combining effects (Cladding TC example)



Thank You